

**Notice of References Cited**

Application/Control No.

10/526,473

Applicant(s)/Patent Under  
Reexamination  
OYAMA ET AL.

Examiner

John L. Goodrow

Art Unit

1756

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,667,140	12-2003	Tosaka et al.	430/108.23
*	B	US-2004/0009294	01-2004	Kuribayashi et al.	427/212
*	C	US-2003/0195274	10-2003	Nakamura et al.	523/160
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.